Search Notes

Applic	ation	Control	No.

Applicant(s)/Patent under Reexamination

10/070,695

THINNES, MARTIN J

Examiner

2858

Hoai-An D. Nguyen

SEARCHED				
Class	Subclass	Date	Examiner	
324	691	6/30/2005	HADN	
324	649, 600	6/30/2005	HADN	
340	870.38	6/30/2005	HADN	
340	870.01	6/30/2005	HADN	
340	870.02	6/30/2005	HADN	
340	870.03	6/30/2005	HADN	
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702	196, 190	6/30/2005	HADN	
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702	104	6/30/2005	HADN	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Text search in EAST.	6/30/2005	HADN
Consulted with Examiner A. Deb.	6/30/2005	HADN